

<b>Notice of References Cited</b>	Application/Control No. 09/844,626	Applicant(s)/Patent Under Reexamination BEATY ET AL.	
	Examiner Sheela C Chawan	Art Unit 2526	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,236,747	05-2001	King et al.	382/149
	C	US-6,118,540	09-2000	Roy et al.	356/394
	D	US-5,617,209	04-1997	Svetkoff et al.	356/608
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Shenghua Ye et al. " Vision -based system calibration for dimensional inspection " Nov 9, 1992, Pages 6.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# **Notice of References Cited**

Application/Control No.  
**09/844,626**

Applicant(s)/Patent Under Reexam  
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Examiner  
**Sheela Chawan**

Art Unit  
**2625**

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<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>2</sup> Dates in MM-YYYY format are publication dates.

<sup>3</sup> Classifications may be U.S. or foreign.